

**General Description**

This planar stripe MOSFET has better characteristics, such as fast switching time, low on resistance, low gate charge and excellent avalanche characteristics. It is mainly suitable for electronic ballast and switch mode power supplies.

**FEATURES**

- $V_{DSS}=800V$ ,  $I_D=7A$
- Drain-Source ON Resistance :  $R_{DS(ON)}=1.55\ \Omega$  @ $V_{GS}=10V$
- $Q_g(\text{typ.})=51.5\text{nC}$

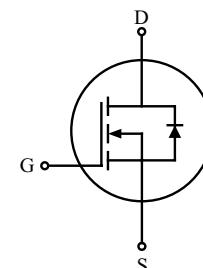
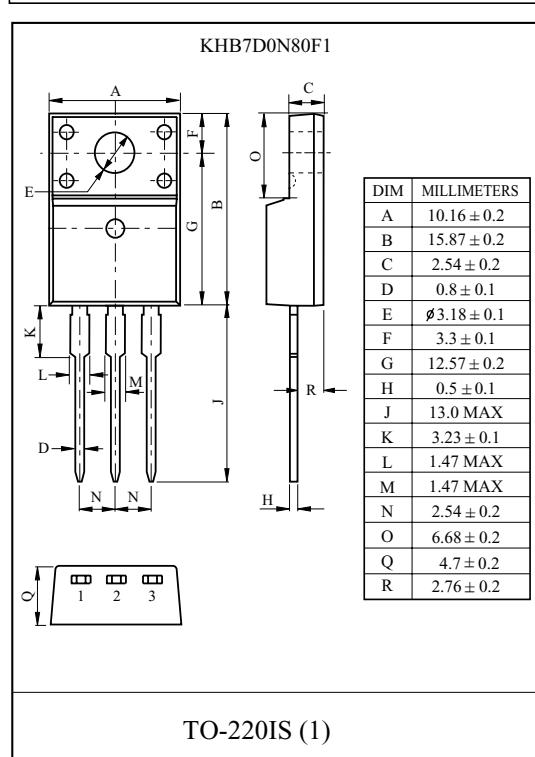
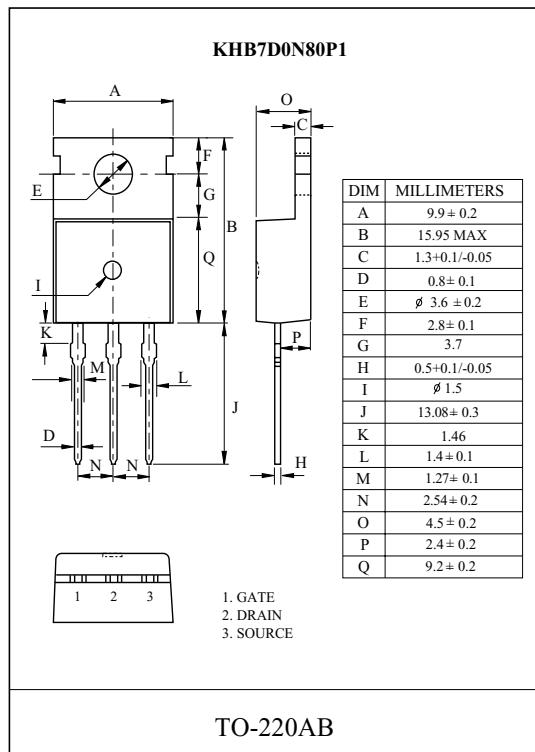
**MAXIMUM RATING (Tc=25 °C)**

CHARACTERISTIC	SYMBOL	RATING		UNIT
		KHB7D0N80P1	KHB7D0N80F1	
Drain-Source Voltage	$V_{DSS}$	800		V
Gate-Source Voltage	$V_{GSS}$	$\pm 30$		V
Drain Current @ $T_c=25\text{ }^\circ\text{C}$	$I_D$	7.0	7.0*	A
	$I_{DP}$	28	28*	
Single Pulsed Avalanche Energy (Note 2)	$E_{AS}$	580		mJ
Repetitive Avalanche Energy (Note 1)	$E_{AR}$	16.7		mJ
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5		V/ns
Drain Power Dissipation	$P_D$	167	56	W
Derate above 25 °C		1.33	0.44	W/°C
Maximum Junction Temperature	$T_j$	150		°C
Storage Temperature Range	$T_{stg}$	-55~150		°C

**Thermal Characteristics**

Thermal Resistance, Junction-to-Case	$R_{thJC}$	0.75	2.25	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{thJA}$	62.5	62.5	°C/W

\* : Drain current limited by maximum junction temperature.



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## ELECTRICAL CHARACTERISTICS (Tc=25 °C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
<b>Static</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	800	-	-	V
Breakdown Voltage Temperature Coefficient	ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	I <sub>D</sub> =250μA, Referenced to 25 °C	-	0.93	-	V/°C
Gate Threshold Voltage	V <sub>th</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.0	-	4.0	V
Drain Cut-off Current	I <sub>DSS</sub>	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V,	-	-	10	μA
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V	-	-	±100	nA
Drain-Source ON Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3.5A	-	1.25	1.55	Ω
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =50V, I <sub>D</sub> =3.5A (Note4)	-	5.5	-	S
<b>Dynamic</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =640V, I <sub>D</sub> =7.0A V <sub>GS</sub> =10V (Note4, 5)	-	51.5	64	nC
Gate-Source Charge	Q <sub>gs</sub>		-	85	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	19.5	-	
Turn-on Delay time	t <sub>d(on)</sub>	V <sub>DD</sub> =400V, R <sub>G</sub> =25 Ω I <sub>D</sub> =7.0A (Note4, 5)	-	39	88	ns
Turn-on Rise time	t <sub>r</sub>		-	63.5	137	
Turn-off Delay time	t <sub>d(off)</sub>		-	195.5	401	
Turn-off Fall time	t <sub>f</sub>		-	83	176	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz	-	1863	2422	pF
Output Capacitance	C <sub>oss</sub>		-	141	184	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	17	23	
<b>Source-Drain Diode Ratings</b>						
Continuous Source Current	I <sub>S</sub>	V <sub>GS</sub> <V <sub>th</sub>	-	-	7.0	A
Pulsed Source Current	I <sub>SP</sub>		-	-	28	
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =7.0A, V <sub>GS</sub> =0V	-	-	1.4	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>S</sub> =7.0A, V <sub>GS</sub> =0V, dI <sub>S</sub> /dt=100A/μs (Note 4)	-	650	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>		-	7.0	-	μC

Note 1) Repetitivity rating : Pulse width limited by junction temperature.

Note 2) L =22mH, I<sub>AS</sub>=7A, V<sub>DD</sub>=50V, R<sub>G</sub>=25 Ω, Starting T<sub>j</sub>=25 °C.

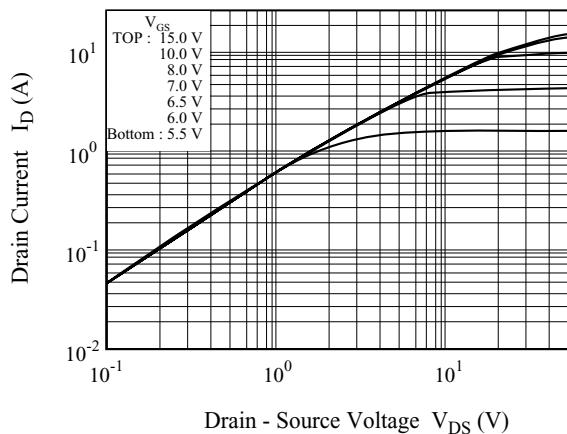
Note 3) I<sub>S</sub> ≤ 8.0A, dI/dt ≤ 200A/μs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Starting T<sub>j</sub>=25 °C.

Note 4) Pulse Test : Pulse width ≤ 300μs, Duty Cycle ≤ 2%.

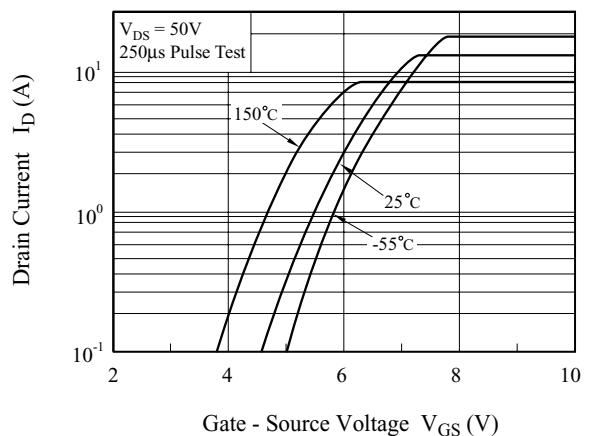
Note 5) Essentially independent of operating temperature.

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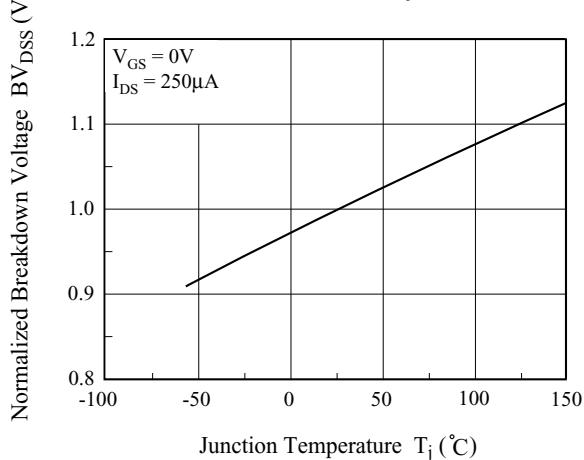
$I_D - V_{DS}$



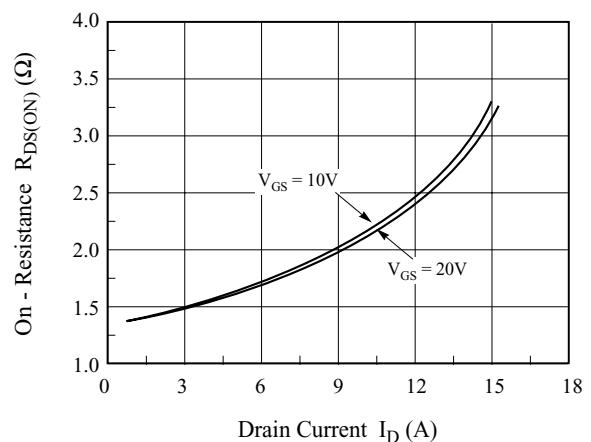
$I_D - V_{GS}$



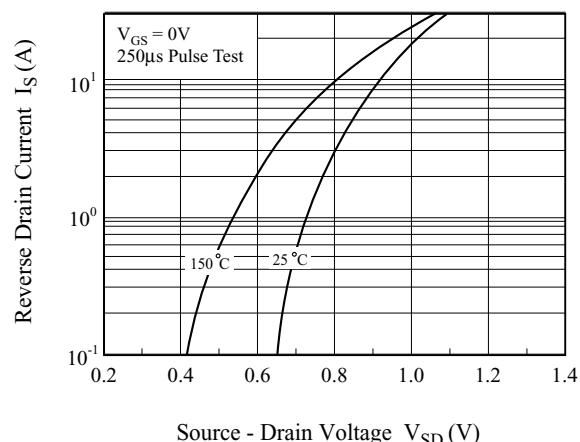
$BV_{DSS} - T_j$



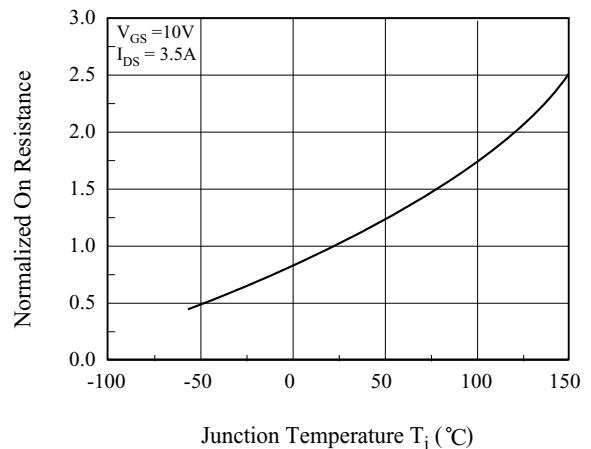
$R_{DS(ON)} - I_D$



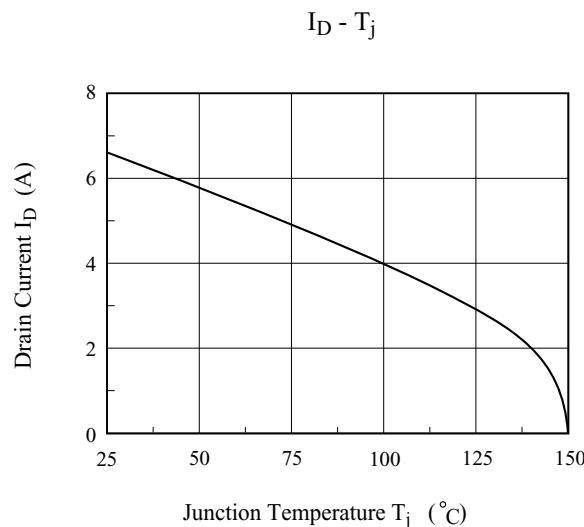
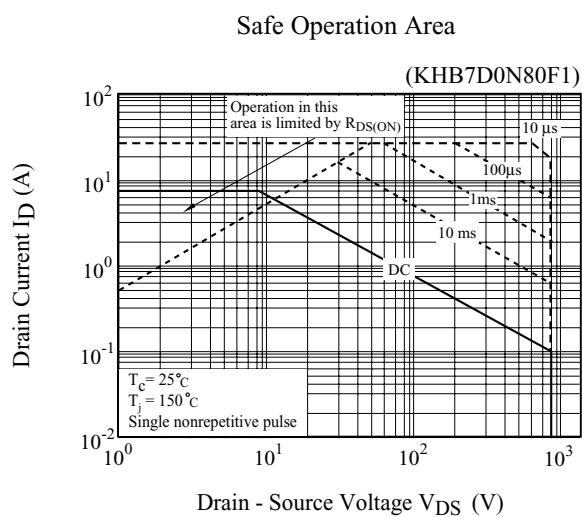
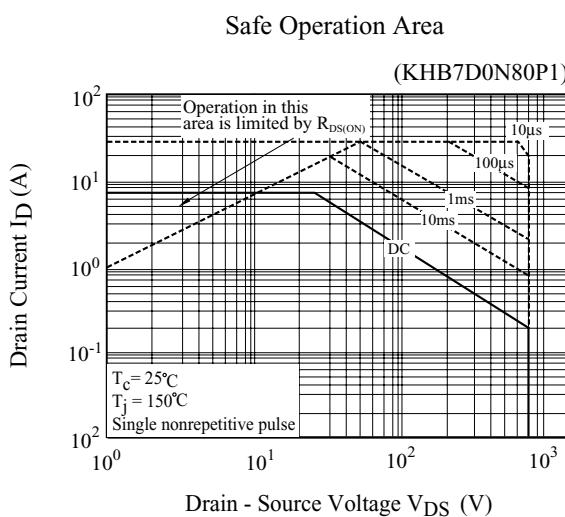
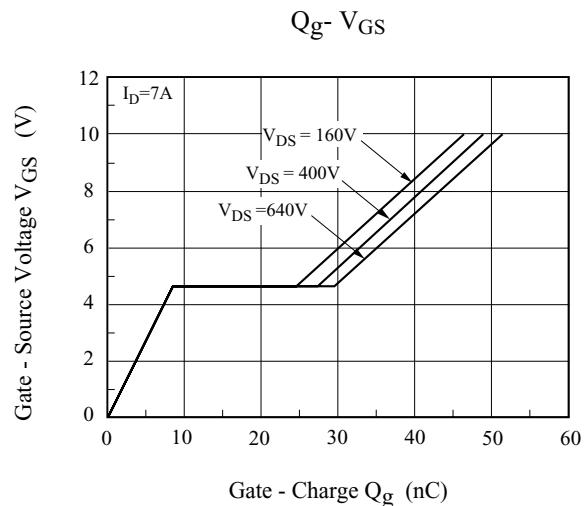
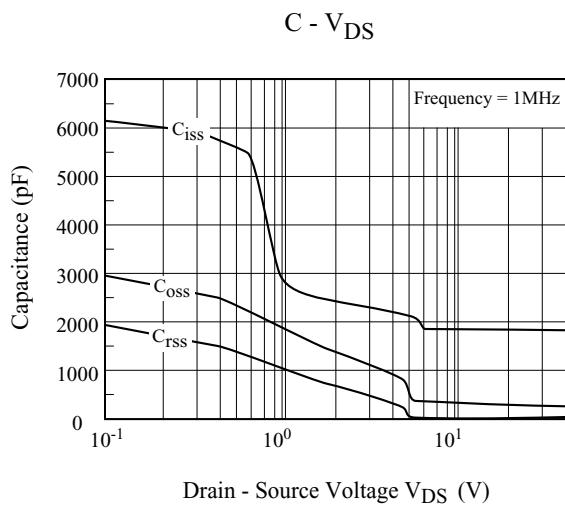
$I_S - V_{SD}$



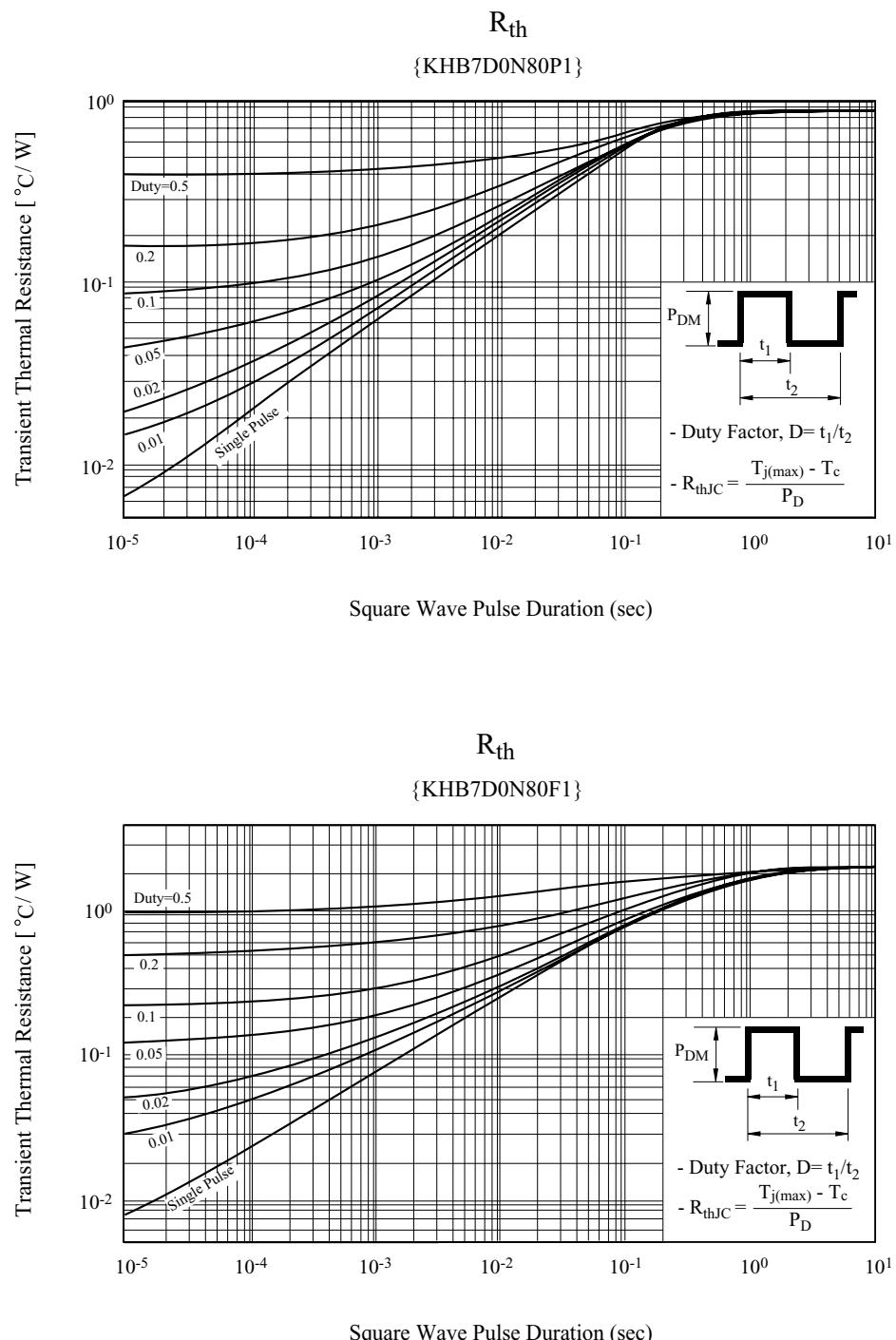
$R_{DS(ON)} - T_j$



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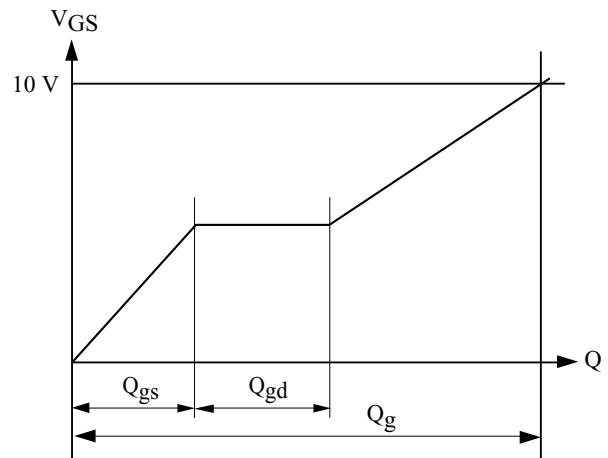
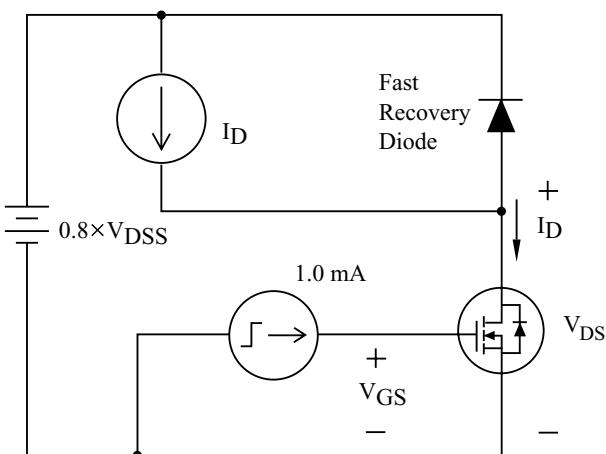


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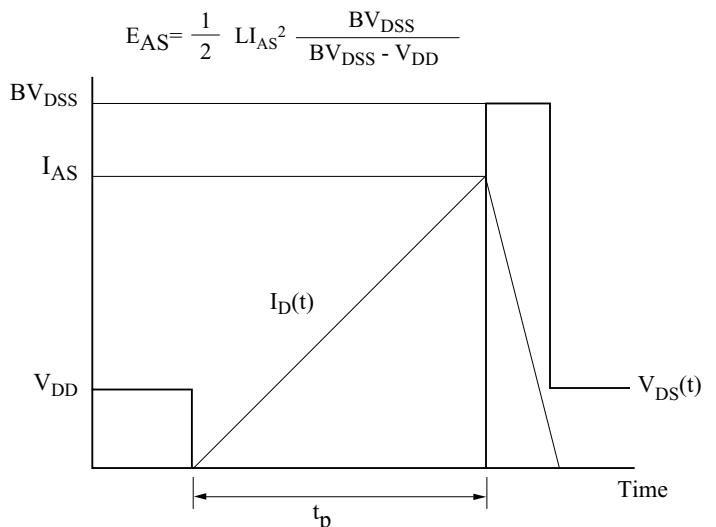
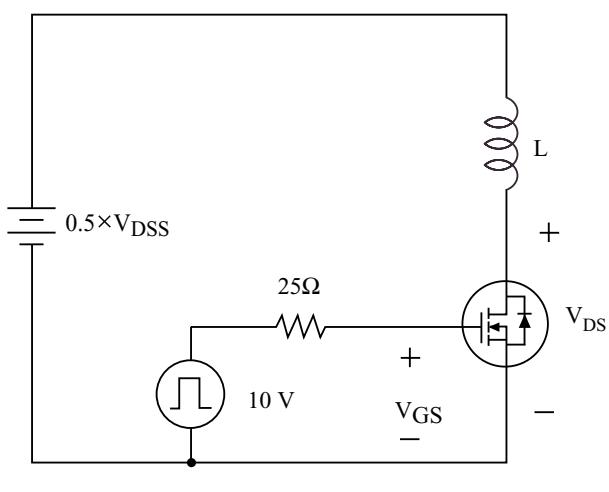


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- Gate Charge

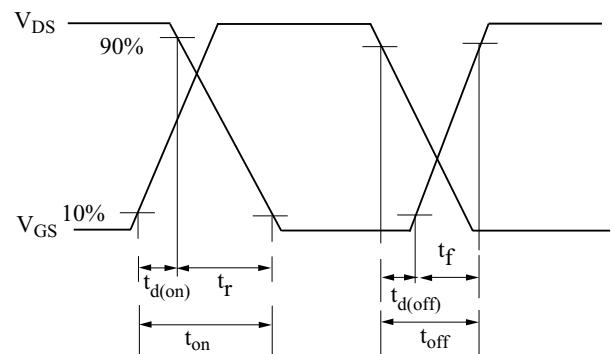
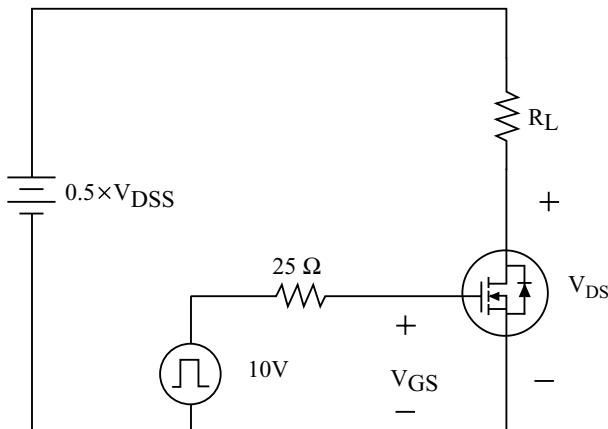


- Single Pulsed Avalanche Energy



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- Resistive Load Switching



- Source - Drain Diode Reverse Recovery and  $dv/dt$

